## Notice of References Cited Application/Control No. 10/767,167 Examiner Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS \* Document Number Country Code-Number-Kind Code MM-YYYYY Mandelman et al. 242,040 \* A US-5.629,580 Application/Control No. Applicant(s)/Patent Under Reexamination MIURA ET AL. Page 1 of 1 Classification Applicant(s)/Patent Under Reexamination MIURA ET AL. Page 1 of 1 Classification

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,629,580	05-1997	Mandelman et al.	313/310
*	В	US-4,991,920	02-1991	Peczalski, Andrzej	385/14
	U	US-			
	D	US-			
	Е	US-			
	F	US-	-		
	G	US-			
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## FOREIGN PATENT DOCUMENTS

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## NON-PATENT DOCUMENTS

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*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	IBM Technical Journal "Field emission triode Integrated Circuit Construction Method," NB8910242 October 1, 1989
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	×	is reference is not being furnished with this Office action. (Co. NDED 5.797.0%)

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.